

Technical documentation



Support &



SN75ALS172A SLLS121E – AUGUST 1990 – REVISED APRIL 2024

SN75ALS172A Quadruple Differential Line Driver

1 Feature

- Meets or exceeds ANSI standards EIA/TIA-422-B and RS-485 and ITU recommendation V.11
- High-speed advanced low-power Schottky circuitry
- Designed for 20MBaud operation in both serial and parallel applications
- Designed for multipoint transmission on long bus lines in noisy environments
- Low supply-current requirements: 55mA max
- Wide positive and negative input/output busvoltage ranges
- Driver output capacity: ±60mA
- Thermal shutdown protection
- Driver positive and negative current limiting
- Logically interchangeable with SN75172

2 Applications

Motor drives

G

G

14

2A

3A

4A

Factory automation and control

3 Description

The SN75ALS172A comprises four line drivers with 3state differential outputs. Which are designed to meet the requirements of ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendation V.11. The device is optimized for balanced multipoint bus transmission at rates of up to 20Mbaud. Each driver features wide positive and negative common-mode output voltage ranges, making the driver suitable for party-line applications in noisy environments.

The SN75ALS172A provides positive- and negativecurrent limiting, and thermal shutdown for protection from line-fault conditions on the transmission bus line. Shutdown occurs at a junction temperature of approximately 150°C.

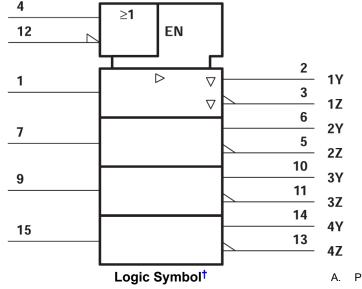
The SN75ALS172A is characterized for operation from 0°C to 70°C.

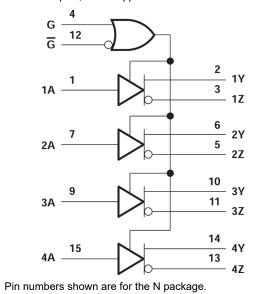
Package Information

i dendge internation						
PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾				
SN75ALS172A	SOIC (DW, 20)	12.8mm × 10.3mm				
	PDIP (N, 16)	19.3mm × 9.4mm				

(1) For more information, see Section 10.

(2) The package size (length × width) is a nominal value and includes pins, where applicable.





Logic Diagram (Positive Logic)

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.



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4 Pin Configuration and Functions

			1
1A [1	O_{16}] V _{CC}] 4A
1Y [2	15] 4A
1Z [3	14] 4Y
G [4	13] 4Z
2Z [2Y [5	12] <u>ิ</u> ดิ
2Y [6	11] 3Z
2A [7	10] 3Y
GND [8	9] 3A

Figure 4-1. N Package (Top View)

Table 4-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		DESCRIPTION
1A	1	I	Driver 1 input
1Y	2	0	Driver 1 output
1Z	3	0	Driver 1 inverted output
G	4	I	Active high enable all drivers
2Z	5	0	Driver 2 inverted output
2Y	6	0	Driver 2 output
2A	7	I	Driver 2 input
GND	8	_	Ground pin
3A	9	I	Driver 3 input
3Y	10	0	Driver 3 output
3Z	11	0	Driver 3 inverted output
G	12	I	Active low enable all drivers
4Z	13	0	Driver 4 inverted output
4Y	14	0	Driver 4 output
4A	15	I	Driver 4 input
V _{CC}	16	_	Power pin

(1) Signal Types: I = Input, O = Output, I/O = Input or Output.



1A [1	U	20	Vcc
1Y 🛛	2		19] 4A
NC 🛛	3		18] 4Y
1Z 🛛	4		17] NC
G [5		16] 4Z
2Z 🛛	6		15] <u>G</u>
NC 🛛	7		14] 3Z
2Y 🛛	8		13] NC
2A 🛛	9		12] 3Y
GND	10		11] 3A

A. NC – No internal connection

Figure 4-2. DW Package (Top View)

Table 4-2. Pin Functions

PIN			TYPE ⁽¹⁾ DESCRIPTION		
NAME	NO.		DESCRIPTION		
1A	1	I	Driver 1 input		
1Y	2	0	Driver 1 output		
NC	3	-	No internal connection		
1Z	4	0	Driver 1 inverted output		
G	5	I	Active high enable all drivers		
2Z	6	0	Driver 2 inverted output		
NC	7	-	No internal connection		
2Y	8	0	Driver 2 output		
2A	9	I	Driver 2 input		
GND	10	-	Ground pin		
3A	11	I	Driver 3 input		
3Y	12	0	Driver 3 output		
NC	13	-	No internal connection		
3Z	14	0	Driver 3 inverted output		
G	15	I	Active low enable all drivers		
4Z	16	0	Driver 4 inverted output		
NC	17	_	No internal connection		
4Y	18	0	Driver 4 output		
4A	19	I	Driver 4 input		
V _{CC}	20		Power pin		

(1) Signal Types: I = Input, O = Output, I/O = Input or Output.



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V _{CC}	Supply voltage, see note ⁽²⁾	-0.3	7	V
VI	Input voltage	-0.3	7	V
Vo	Output voltage range	-9	14	V
P _D	Continuous total dissipation	See Dissipation Rating Table		
T _{stg}	Storage temperature range	-65	150	°C
T _{LEAD}	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal.

5.2 Dissipation Rating Table

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DW	1125 mW	9 mW/°C	720 mW	585 mW
Ν	1150 mW	9.2 mW/°C	736 mW	598 mW

5.3 Recommended Operating Conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}	4.75	5	5.25	V
High-level input voltage, V _{IH}	2			V
Low-level input voltage, V _{IL}			0.8	V
Common-mode output voltage, V _{OC}	-7		12	V
High-level output current, I _{OH}			-60	mA
Low-level output current, I _{OL}			60	mA
Operating free-air temperature, T _A	0		70	°C

5.4 Thermal Information

		DW (SOIC)	N (PDIP)	UNIT
		20-Pins	16-Pins	UNIT
R _{θJA}	Junction-to-ambient thermal resistance	66.8	60.6	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	34.4	48.1	°C/W
R _{θJB}	Junction-to-board thermal resistance	39.7	40.6	°C/W
TLΨ	Junction-to-top characterization parameter	8.9	27.5	°C/W
Ψјв	Junction-to-board characterization parameter	39.0	40.3	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	n/a	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC package thermal metrics* application report.



5.5 Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS		MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IK}	Input clamp voltage	I _I = -18mA	I _I = -18mA				-1.5	V
Vo	Output voltage	I _O = 0			0		6	V
V _{OD1}	Differential output voltage	I _o = 0			1.5		6	V
V _{OD2}	Differential output voltage	V _{CC} = 5V,	R _L = 100Ω,	See Figure 6-1	1/2V _{OD1} or 2 ⁽²⁾			V
		$R_L = 54\Omega$,	See Figure 6	-1	1.5	2.5	5	
V _{OD3}	Differential output voltage	See Note 2			1.5		5	V
Δ V _{OD}	Change in magnitude of differential output voltage ⁽³⁾	$R_L = 54\Omega \text{ or } 100\Omega,$	See Figure 6-1				±0.2	V
V _{oc}	Common-mode output voltage ⁽⁴⁾	$R_L = 54\Omega \text{ or } 100\Omega,$	See Figure 6-1		-1		3	V
Δ V _{OC}	Change in magnitude of common-mode output voltage ⁽³⁾	$R_L = 54\Omega \text{ or } 100\Omega,$	or 100Ω, See Figure 6-1				±0.2	V
lo	Output current with power off	V _{CC} = 0,	V _O = -7V to 1	2V			±100	μA
l _{oz}	High-impedance-state output current	$V_0 = -7V$ to 12V					±100	μA
I _{IH}	High-level input current	V _I = 2.7V	V ₁ = 2.7V				20	μA
IIL	Low-level input current	V _I = 0.4V				-100	μA	
l _{os}	Short-circuit output current	V ₀ = -7V to 12V				±250	mA	
1	Supply current (all drivers)	No load	Outputs enab	oled		36	55	m۸
I _{CC}			Outputs disat	bled		15	30	mA

(1) All typical values are at V_{CC} = 5V and T_A = 25°C.

(2) The minimum V_{OD2} with a 100 Ω load is either 1/2 V_{OD1} or 2V, whichever is greater.

(3) $\Delta |V_{OD}|$ and $\Delta |V_{OC}|$ are the changes in magnitude of V_{OD} and V_{OC} , respectively, that occur when the input is changed from a high level to a low level.

(4) In ANSI Standard EIA/TIA-422-B, V_{OC}, which is the average of the two output voltages with respect to ground, is called output offset voltage, V_{OS}.

(5) See EIA Standard RS-485, Figure 6-3-5, Test Termination Measurement 2.

5.6 Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature, CL = 50pF

	PARAMETER	TEST CC	NDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{d(OD)}	Differential-output delay time	R _L = 54Ω,	See Figure 6-2	9	15	22	ns
t _{PZH}	Output enable time to high level	R _L = 110Ω,	See Figure 6-3	30	45	70	ns
t _{PZL}	Output enable time to low level	RL = 110Ω,	See Figure 6-4	25	40	65	ns
t _{PHZ}	Output disable time from high level	R _L = 110Ω,	See Figure 6-3	10	20	35	ns
t _{PLZ}	Output disable time from low level	R _L = 110Ω,	See Figure 6-4	10	30	45	ns

(1) All typical values are at V_{CC} = 5V and T_A = 25°C.



6 Parameter Measurement Information

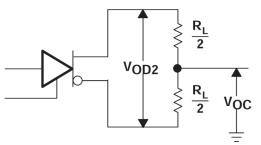
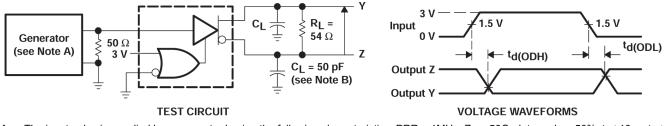


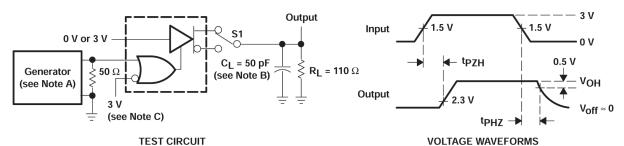
Figure 6-1. Differential and Common-Mode Output Voltages



A. The input pulse is supplied by a generator having the following characteristics: PRR = 1MHz, $Z_0 = 50\Omega$, duty cycle = 50%, $t_f \le 10$ ns, $t_r \le 10$ ns.

B. CL includes probe and stray capacitance.

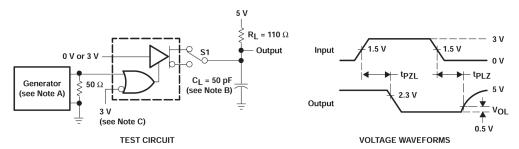
Figure 6-2. Differential Output Test Circuit and Voltage Waveforms



A. The input pulse is supplied by a generator having the following characteristics: PRR = 1MHz, Z_O = 50Ω, duty cycle = 50%, t_f ≤ 5ns, t_r ≤ 5ns.

- B. C_L includes probe and stray capacitance.
- C. To test the active-low enable \overline{G} , ground G and apply an inverted input waveform to \overline{G} .





- A. The input pulse is supplied by a generator having the following characteristics: PRR = 1MHz, Z₀ = 50Ω, duty cycle = 50%, t_f ≤ 5ns, t_r ≤ 5ns.
- B. C_L includes probe and stray capacitance.
- C. To test the active-low enable G, ground \overline{G} and apply an inverted input waveform to \overline{G} .

Figure 6-4. Test Circuit and Voltage Waveforms, T_{PZL} and T_{PLZ}



7 Detailed Description

7.1 Device Functional Modes

Table 7-1. Function Table (Each Driver)

INPUT ⁽¹⁾		ENABLES	OUTPUTS				
Α	G	G	Y	Z			
Н	Н	Х	Н	L			
L	н	Х	L	Н			
Н	Х	L	Н	L			
L	Х	L	L	Н			
X	L	Н	Z	Z			

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off)

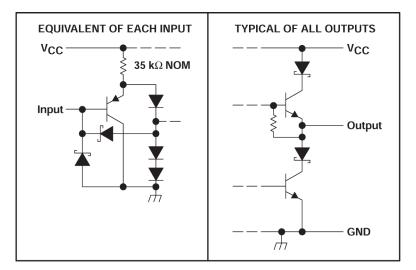


Figure 7-1. Schematics of Inputs and Outputs



8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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8.3 Trademarks

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8.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

C	hanges from Revision D (April 1998) to Revision E (April 2024)	Page
•	Changed the numbering format for tables, figures, and cross-references throughout the document	1
•	Added the Thermal Information table	5
•	Changed Note A in Figure 6-2	7

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	-	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
SN75ALS172ADW	OBSOLETE	SOIC	DW	20		TBD	Call TI	Call TI	0 to 70	75ALS172A	
SN75ALS172ADWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS172A	Samples
SN75ALS172AN	ACTIVE	PDIP	Ν	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	SN75ALS172AN	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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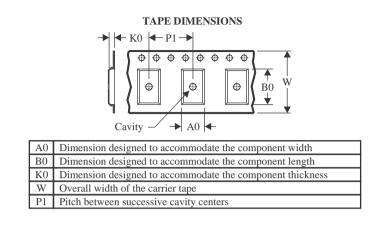


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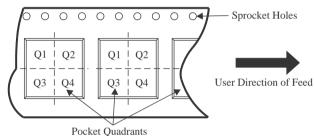
NSTRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN75ALS172ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1



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PACKAGE MATERIALS INFORMATION

6-Apr-2024



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN75ALS172ADWR	SOIC	DW	20	2000	367.0	367.0	45.0	

TEXAS INSTRUMENTS

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TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN75ALS172ADW	DW	SOIC	20	25	507	12.83	5080	6.6
SN75ALS172ADW	DW	SOIC	20	25	506.98	12.7	4826	6.6
SN75ALS172AN	N	PDIP	16	25	506	13.97	11230	4.32

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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